

Notice of References Cited	Application/Control No. 09/887,781		Applicant(s)/Patent Under Reexamination ANN ET AL.	
	Examiner Tan Dean D. Nguyen		Art Unit 3689	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-7,162,427	01-2007	Myrick et al.	705/1
*	B	US-6,697,824	02-2004	Bowman-Amuah, Michel K.	709/229
*	C	US-2004/0059611	03-2004	Kananghinis et al.	705/007
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	K	US-			
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	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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